

Search Notes (continued)**Application/Control No.**

10/696,203

Examiner

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Applicant(s)/Patent under Reexamination

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Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	19	6/6/2006	JSL
716	21	6/6/2006	JSL
716	1	6/6/2006	JSL
716	2	6/6/2006	JSL
716	4	6/6/2006	JSL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST [USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB]	6/6/2006	JSL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
716	1,2,4	6/6/2006	JSL
716	19	6/6/2006	JSL
716	21	6/6/2006	JSL